

## Metal Composite Power Inductor (Thin Film) **Specification Sheet**



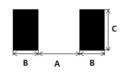
## CIGT201610EH2R2MNE (2016 / EIA 0806)

Smart phones, Tablet, Wearable devices, Power converter modules, etc.

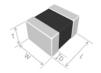


### **FEATURES**

Small power inductor for mobile devices Low DCR structure and high efficiency inductor for power circuits. Monolithic structure for high reliability Free of all RoHS-regulated substances Halogen free



	Unit : mm
TYPE	2016
Α	0.8
В	0.8
С	1.8



TYPE	Dimension [mm]						
III	L	W	T	D			
2016	2.0±0.2	1.6±0.2	1.0 max	0.5±0.2			

Part no.	Size	Size Thickness	Inductance tolerance		DC Resist	ance [mΩ]	Rated DC Cu	rrent (Isat) [A]	Rated DC C	urrent (Irms) A]
raitiio.	[inch/mm]	[mm] (max)	[uH]	(%)	Max.	Тур.	Max.	Тур.	Max.	Тур.
CIGT201610EH2R2MNE	0806/2016	1.0	2.2	±20	87	73	2.7	2.9	2.5	2.7

- \* Inductance : Measured with a LCR meter 4991A(Agilent) or equivalent (Test Freq. 1MHz, Level 0.1V)
- \* DC Resistance : Measured with a Resistance HI-TESTER 3541(HIOKI) or equivalent
- \* Maximum allowable DC current: Value defined when DC current flows and the initial value of inductance has decreased by 30% or

when current flows and temperature has risen to 40℃ whichever is smaller. (Reference: ambient temperature is 25℃±10)

(Isat): Allowable current in DC saturation: The DC saturation allowable current value is specified when the decrease of

the initial inductance value at 30% (Reference: ambient temperature is  $25\,^{\circ}\text{C}\pm10$ )

(Irms): Allowable current of temperature rise: The temperature rise allowable current value is specified when temperature of

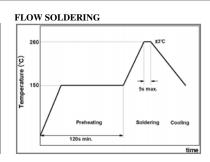
- \* Absolute maximum voltage : Absolute maximum voltage DC 20V.
- $^{\star}$  Operating temperature range : -40 to +125°C (Including self-temperature rise)

<u>CIG</u>	<u>T</u>	<u>2016</u>	<u>10</u>	<u>EH</u>	<u>2R2</u>	M	<u>N</u>	<u>E</u>
(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	(9)

- (1) Power Inductor
- (3) Dimensior (2016: 2.0mm ×1.6 mm)
- (5) Remark (Characterization Code)
- (7) Toleranc (M:±20%)
- (8) Internal Code
- (9) Packaging (C:paper tape, E:embossed tape)
- (T: Metal Composite Thin Film Type) (2) Type
- (4) Thicknes (10: 1.0mm)
- (6) Inductani (2R2: 2.2 uH)

## RECOMMENDED SOLDERING CONDITION

# REFLOW SOLDERING 230 emperature ('C)



IRON SOLDERING	
Temperature of	280 ℃ max.
Soldering Iron Tip	280 C max.
Preheating	150℃min.
Temperature	130 CIIIII.
Temperature	ΔT≤130℃
Differential	$\Delta 1 \ge 130 \text{ C}$
Soldering Time	3sec max.
Wattage	50W max.

Packaging Style	Quantity(pcs/reel)
Embossed Taping	3000 pcs

Item	Specified Value	Test Condition			
Solderability	More than 90% of terminal electrode should be soldered newly.	After being dipped in flux for $4\pm1$ seconds, and preheated at $150\sim180$ °C for $2\sim3$ min, the specimen shall be immersed in solder at $245\pm5$ °C for $4\pm1$ seconds.			
Resistance to Soldering	No mechanical damage. Remaining terminal Electrode: 75% min. Inductance change to be within ±20% to the initial.	After being dipped in flux for 4±1 seconds, and preheated at $150 \sim 180^{\circ}$ for $2 \sim 3$ min, the specimen shall be immersed in solder at $260\pm5^{\circ}$ for $10\pm0.5$ seconds.			
Thermal Shock (Temperature Cycle test)	No mechanical damage Inductance change to be within ±20% to the initial.	Repeat 100 cycles under the following conditions. -40±3 ℃ for 30 min → 85±3 ℃ for 30 min			
High Temp. Humidity Resistance Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, 85%RH, for 500±12 hours.  Measure the test items after leaving at normal temperature and humidity for 24 hours.			
Low Temperature Test	No mechanical damage Inductance change to be within ±20% to the initial.	Solder the sample on PCB. Exposure at -55±2°C for 500±12 hours.  Measure the test items after leaving at normal temperature and humidity for 24hours.			
High Temperature Test	No mechanical damage Inductance change to be within ±20% to the initial.	Solder the sample on PCB. Exposure at 125±2°C for 500±12 hours.  Measure the test items after leaving at normal temperature and humidity for 24hours.			
High Temp. Humidity Resistance Loading Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, 85%RH, Rated Current for 500±12 hours.  Measure the test items after leaving at normal temperature and humidity for 24 hours.			
High Temperature Loading Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, Rated Current for 500±12 hours.  Measure the test items after leaving at normal temperature and humidity for 24 hours.			
Reflow Test	No mechanical damage Inductance change to be within ±20% to the initial	Peak 260±5°C, 3 times  Solder the sample on PCB. Vibrate as apply 10~55Hz, 1.5mn amplitude for 2 hours in each of three(X,Y,Z) axis (total 6 hours).			
Vibration Test	No mechanical damage Inductance change to be within ±20% to the initial.				
	No mechanical damage	Bending Limit; 2mm Test Speed; 1.0mm/sec. Keep the test board at the limit point in 5 sec. PCB thickness: 1.6mm			
Bending Test	19	20 Unit :mm			
	46	45			
	No indication of peeling shall occur on the	W(kgf) TIME(sec)			
	terminal electrode.	0.5 10±1			
Terminal Adhesion Test					
Drop Test	No mechanical damage Inductance change to be within ±20% to the initial.	Random Free Fall test on concrete plate. 1 meter, 10 drops			
lpeak (AC+DC Load Life)	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, 85%RH, Load(Ipeak) for 120 hours. (Frequncy:1MHz, Load(Ipeak):1.5hr on / 0.5hr off) Measure the test items after leaving at normal temperature and humidity for 24 hours. * Load(Ipeak) = Irms(max)×1.4			



# Metal Composite Power Inductor (Thin Film)

## RoHS+Halogen Compliant

## **Data Sheet**

## 1. Model: CIGT201610EH2R2MNE

### 2. Description

Part no.	Size	Thickness	Inductance	Inductance tolerance (%)	DC Resist	ance [mΩ]	Rated DC Cu	rrent (Isat) [A]	Rated DC C	` ,
i aitiio.	[inch/mm]	[mm] (max)	[uH]		Max.	Тур.	Max.	Тур.	Max.	Тур.
CIGT201610EH2R2MNE	0806/2016	1.0	2.2	±20	87	73	2.7	2.9	2.5	2.7

<sup>\*</sup> Inductance : Measured with a LCR meter 4991A(Agilent) or equivalent (Test Freq. 1MHz, Level 0.1V)

(Isat) : Allowable current in DC saturation : The DC saturation allowable current value is specified when the decrease of the initial inductance value at 30% (Reference: ambient temperature is 25 ℃±10)

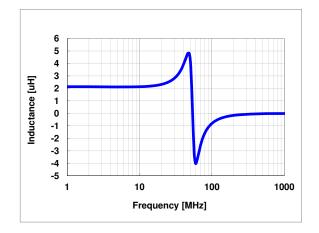
(Irms) : Allowable current of temperature rise : The temperature rise allowable current value is specified when temperature of the inductor is raised 40 ℃ by DC current. (Reference: ambient temperature is 25 ℃±10)

- \* Absolute maximum voltage: Absolute maximum voltage DC 20V.
- \* Operating temperature range : -40 to +125°C (Including self-temperature rise)

### 3. Characteristics data

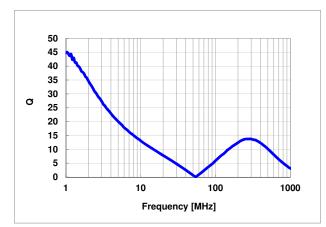
### 1) Frequency characteristics (Ls)

Agilent E4294A +E4991A , 1MHz to 1,000MHz

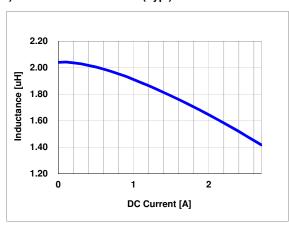


### 2) Frequency characteristics (Q)

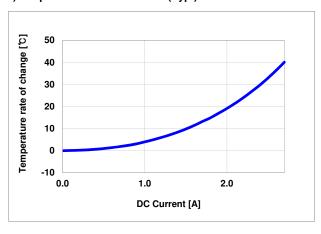
Agilent E4294A +E4991A , 1MHz to 1,000MHz



### 3) DC Bias characteristics (Typ.)



### 4)Temperature characteristics (Typ.)





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